

Description

The Si2347DS-T1-GE3 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.



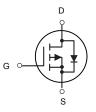
General Features

 $V_{DS} = -30V, I_{D} = -6A$

 $R_{DS(ON)}$ <35m Ω @ V_{GS} =10V

Application

High power and current handing capability Lead free product is acquired Surface mount package PWM applications Load switch Power management



P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
Si2347DS-T1-GE3	SOT-23	HXY MOSFET	3000

Absolute Maximum Ratings (T_A=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
VDS	Drain-Source Voltage	-30	V
V _G s	Gate-Source Voltage	±20	V
I _D	Drain Current-Continuous	-6	Α
Ідм	Drain Current-Pulsed (Note 1)	-24	Α
P _D	Maximum Power Dissipation	1.32	W
T _J ,T _{STG}	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}$
Reja	Thermal Resistance,Junction-to-Ambient (Note 2)	125	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V	
$\triangle BV_{\text{DSS}}/\triangle T$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.022		V/°C	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-4A		28	35	mO	
	Static Dialii-Source On-Resistance	V _{GS} =-4.5V , I _D =-2A	V _{GS} =-4.5V , I _D =-2A 40		55	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	VV I- = 250uA	-1.0		-2.5	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		4.6		mV/°C	
l	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			1		
I _{DSS}		V _{DS} =-24V , V _{GS} =0V , T _J =55°C	s=-24V , V _{GS} =0V , T _J =55°C		5	- uA	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-4A		15		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13		Ω	
Qg	Total Gate Charge (-4.5V)			9.7			
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-4A		2.5		nC	
Q_{gd}	Gate-Drain Charge			3			
T _{d(on)}	Turn-On Delay Time			16.4			
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_{G} =3.3 Ω ,		20.2		- ns	
$T_{d(off)}$	Turn-Off Delay Time	I _D =-4A		55			
T _f	Fall Time			10			
Ciss	Input Capacitance			750			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		150		pF	
Crss	Reverse Transfer Capacitance			127			
Is	Continuous Source Current ^{1,4}	V -V -0V Faras Current			-6.0	Α	
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			-24	Α	
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V	
t _{rr}	Reverse Recovery Time			18.3		nS	
Qrr	Reverse Recovery Charge	IF=-4A , dI/dt=100A/μs , T _J =25°C		7.2		nC	

Note

^{1.} The data tested by surface mounted on a 1 inch $^2\,\text{FR-4}$ board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

^{3.}The power dissipation is limited by 150°C junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

Typical Characteristics

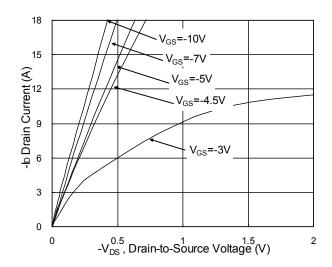


Fig.1 Typical Output Characteristics

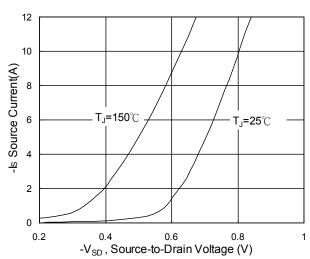


Fig.3 Forward Characteristics of Reverse

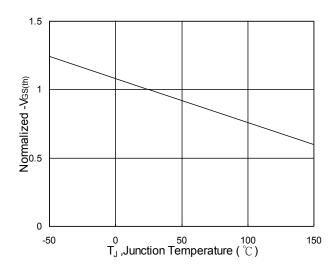


Fig.5 Normalized $V_{\text{GS(th)}}$ v.s T_{J}

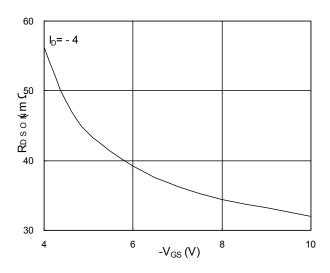


Fig.2 On-Resistance v.s Gate-Source

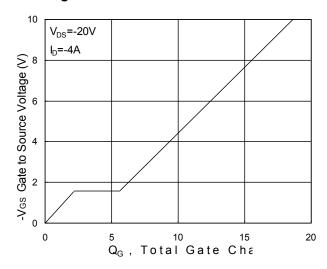


Fig.4 Gate-Charge Characteristics

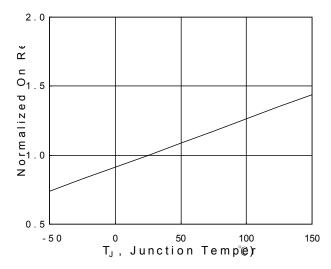
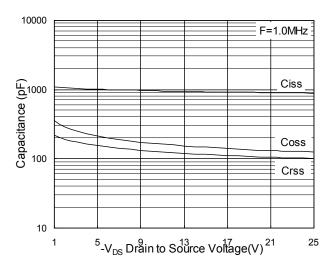


Fig.6 Normalized R_{DSON} v.s T_J



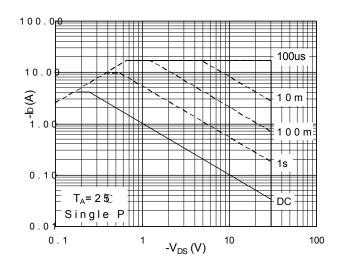


Fig.7 Capacitance

Fig.8 Safe Operating Area

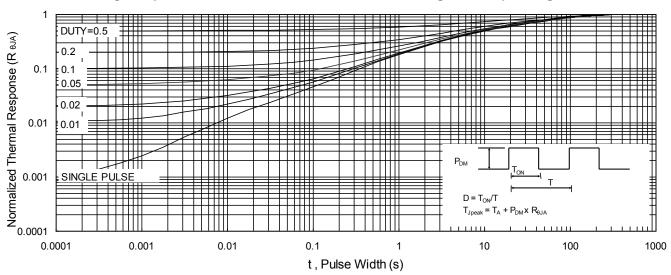


Fig.9 Normalized Maximum Transient Thermal Impedance

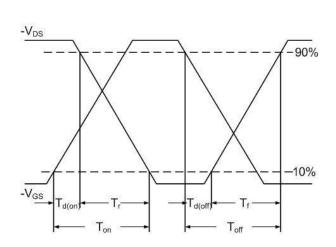


Fig.10 Switching Time Waveform

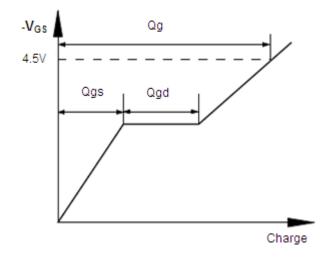
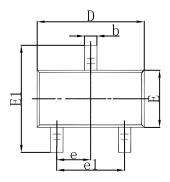
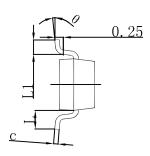
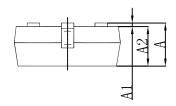


Fig.11 Gate Charge Waveform

SOT-23 Package Outline Dimensions

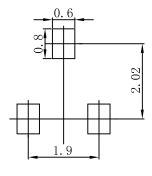






Cumphel	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950	0 TYP 0.037 TYP		TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022 REF		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

SOT-23 Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.



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